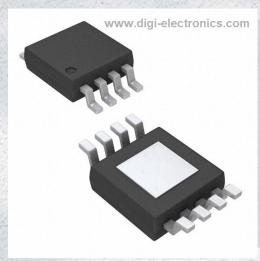


# **THS4061IDGNR Datasheet**



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DiGi Electronics Part Number THS4061IDGNR-DG

Manufacturer Texas Instruments

Manufacturer Product Number THS4061IDGNR

Description IC OPAMP VFB 1 CIRCUIT 8HVSSOP

Detailed Description Voltage Feedback Amplifier 1 Circuit 8-HVSSOP



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RFQ Email: Info@DiGi-Electronics.com

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# **Purchase and inquiry**

Manufacturer Product Number:	Manufacturer:
THS4061IDGNR	Texas Instruments
Series:	Product Status:
	Active
Amplifier Type:	Number of Circuits:
Voltage Feedback	1
Output Type:	Slew Rate:
	400V/µs
-3db Bandwidth:	Current - Input Bias:
180 MHz	3 μΑ
Voltage - Input Offset:	Current - Supply:
2.5 mV	7.8mA
Current - Output / Channel:	Voltage - Supply Span (Min):
115 mA	9 V
Voltage - Supply Span (Max):	Operating Temperature:
33 V	-40°C ~ 85°C
Mounting Type:	Package / Case:
Surface Mount	8-TSSOP, 8-MSOP (0.118", 3.00mm Width) Exposed Pad
Supplier Device Package:	Base Product Number:
8-HVSSOP	THS4061

# **Environmental & Export classification**

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

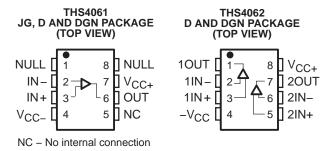
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- High Speed
  - 180 MHz Bandwidth (G = 1, -3 dB)
  - 400 V/us Slew Rate
  - 40-ns Settling Time (0.1%)
- High Output Drive, I<sub>O</sub> = 115 mA (typ)
- Excellent Video Performance
  - 75 MHz 0.1 dB Bandwidth (G = 1)
  - 0.02% Differential Gain
  - 0.02° Differential Phase
- Very Low Distortion
  - THD = -72 dBc at f = 1 MHz
- Wide Range of Power Supplies
  - $V_{CC}$  =  $\pm 5$  V to  $\pm 15$  V
- Available in Standard SOIC, MSOP PowerPAD™, JG, or FK Package
- Evaluation Module Available

#### description

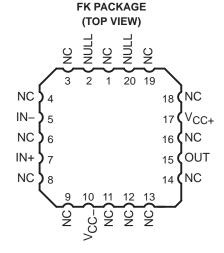
The THS4061 and THS4062 are generalpurpose, single/dual, high-speed voltage feedback amplifiers ideal for a wide range of applications including video, communication, and imaging. The devices offer very good ac performance with 180-MHz bandwidth, 400-V/µs slew rate, and 40-ns settling time (0.1%). The THS4061/2 are stable at all gains for both inverting and noninverting configurations. These amplifiers have a high output drive capability of 115 mA and draw only 7.8 mA supply current per channel. Excellent professional video results can be obtained with the low differential gain/phase errors of 0.02%/0.02° and wide 0.1 db flatness to 75 MHz. For applications requiring low distortion, the THS4061/2 is ideally suited with total harmonic distortion of -72 dBc at f = 1 MHz.

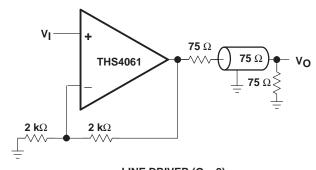




Cross-Section View Showing PowerPAD Option (DGN)

THS4061









CAUTION: The THS4061 and THS4062 provide ESD protection circuitry. However, permanent damage can still occur if this device is subjected to high-energy electrostatic discharges. Proper ESD precautions are recommended to avoid any performance degradation or loss of functionality



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PowerPAD is a trademark of Texas Instruments Incorporated.



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RELATED DEVICES					
DEVICE DESCRIPTION					
THS4011/2	290-MHz Low Distortion High-Speed Amplifiers				
THS4031/2	100-MHz Low Noise High Speed-Amplifiers				
THS4061/2	180-MHz High-Speed Amplifiers				

#### **AVAILABLE OPTIONS**

			PACKAGED	DEVICES			
TA	NUMBER OF CHANNELS	PLASTIC SMALL OUTLINE <sup>†</sup> (D)	PLASTIC MSOP† (DGN)	CERAMIC DIP (JG)	CHIP CARRIER (FK)	MSOP SYMBOL	EVALUATION MODULES
0°C to	1	THS4061CD	THS4061CDGN	_	_	TIABS	THS4061EVM
70°C	2	THS4062CD	THS4062CDGN	_	_	TIABM	THS4062EVM
−40°C to	1	THS4061ID	THS4061IDGN	_	_	TIABT	_
85°C	2	THS4062ID	THS4062IDGN	_	_	TIABN	_
–55°C to 125°C	1	_	_	THS4061MJG	THS4061MFK	_	_

<sup>†</sup> The D and DGN packages are available taped and reeled. Add an R suffix to the device type (i.e., THS4061CDGNR).

#### functional block diagram

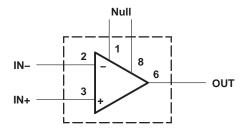


Figure 1. THS4061 – Single Channel

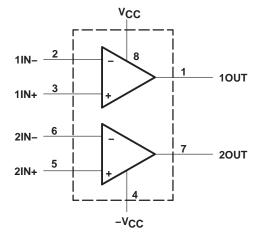


Figure 2. THS4062 - Dual Channel



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## absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V <sub>CC</sub> + to V <sub>CC</sub>		
Input voltage, V <sub>I</sub>		±V <sub>CC</sub>
Output current, IO		
Continuous total power dissipation		See Dissipation Rating Table
Maximum junction temperature, T <sub>J</sub>		150°C
Operating free-air temperature, T <sub>A</sub> :	C-suffix	0°C to 70°C
	I-suffix	–40°C to 85°C
	M-suffix	–55°C to 125°C
Storage temperature, T <sub>stg</sub>		–65°C to 150°C
Lead temperature 1,6 mm (1/16 inc	h) from case for 10 seconds, D and DGN pa	ackage 300°C
Lead temperature 1,6 mm (1/16 inc	h) from case for 60 seconds, JG package	300°C
Case temperature for 60 seconds, F	K package	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### **DISSIPATION RATING TABLE**

PACKAGE	T <sub>A</sub> ≤ 25°C POWER RATING	7.		T <sub>A</sub> = 85°C POWER RATING	T <sub>A</sub> = 125°C POWER RATING
D	740 mW	6 mW/°C	475 mW	385 mW	_
DGN <sup>‡</sup>	2.14 W	17.1 mW/°C	1.37 W	1.11 W	_
JG	1057 mW	8.4 mW/°C	627 mW	546 mW	210 mW
FK	1375 mW	11 mW/°C	880 mW	715 mW	275 mW

<sup>&</sup>lt;sup>‡</sup> The DGN package incorporates a PowerPAD on the underside of the device. This acts as a heatsink and must be connected to a thermal dissipation plane for proper power dissipation. Failure to do so can result in exceeding the maximum specified junction temperature, which could permanently damage the device.

#### recommended operating conditions

		MIN	NOM MAX	UNIT
Supply voltage, V <sub>CC</sub> + and V <sub>CC</sub> -	Dual supply	±4.5	±16	.,
	Single supply	9	32	V
	C-suffix	0	70	
Operating free-air temperature, TA	I-suffix	-40	85	°C
	M-suffix	-55	125	

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# electrical characteristics at T<sub>A</sub> = 25°C, V<sub>CC</sub> = $\pm 15$ V, R<sub>L</sub> = 150 $\Omega$ (unless otherwise noted)

#### dynamic performance

PARAMETER		TEST CONDITIONS†		THS4061C/I, THS4062C/I			UNIT	
				MIN	TYP	MAX		
		V <sub>CC</sub> = ±5 V	Gain = 1		180		MHz	
	Dynamic performance small-signal bandwidth (–3 dB)	V <sub>CC</sub> = ±15 V	Onto 4		50		N.41.1-	
BW	bandwidth (=3 db)	V <sub>CC</sub> = ±5 V	Gain = -1	50		MHz		
	Donahuidth fan C. 1. dD flatages	V <sub>CC</sub> = ±15 V	Coin 4		75		N 41 1-	
	Bandwidth for 0.1 dB flatness	V <sub>CC</sub> = ±5 V	Gain = 1		20		MHz	
0.0	Olemente	$V_{CC} = \pm 15 \text{ V}$	Onto 4		400		\// -	
SR	Slew rate	V <sub>CC</sub> = ±5 V	Gain = -1		350		V/μs	
	Contilion times to 0.404	$V_{CC} = \pm 15 \text{ V},  5-\text{V step } (0 \text{ V to } 5 \text{ V})$	Onin 4		40			
_	Settling time to 0.1%	$V_{CC} = \pm 5 \text{ V}, \qquad V_{O} = -2.5 \text{ V to } 2.5 \text{ V},$	Gain = -1		40		ns	
t <sub>S</sub>	Sottling time to 0.049/	$V_{CC} = \pm 15 \text{ V},  5-\text{V step } (0 \text{ V to } 5 \text{ V})$	Coin 1		140			
	Settling time to 0.01%	$V_{CC} = \pm 5 \text{ V}, \qquad V_{O} = -2.5 \text{ V to } 2.5 \text{ V},$	Gain = -1		150		ns	

<sup>†</sup> Full range = 0°C to 70°C for C suffix and -40°C to 85°C for I suffix

#### noise/distortion performance

PARAMETER		TEST CONDITIONS <sup>†</sup>			THS4061C/I, THS4062C/I			UNIT
					MIN	TYP	MAX	
THD	Total harmonic distortion	f = 1 MHz				-72		dBc
٧n	Input voltage noise	f = 10 kHz,	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$			14.5		nV/√ <del>Hz</del>
In	Input current noise	f = 10 kHz,	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$			1.6		pA/√Hz
	<b>5</b> 16			V <sub>CC</sub> = ±15 V		0.02 %		
	Differential gain error	Gain = 2,	NTSC, 40 IRE modulation	V <sub>CC</sub> = ±5 V		0.02 %		
	<b>5</b> //		NEO (010E 1111	V <sub>CC</sub> = ±15 V		0.02°		
	Differential phase error	Gain = 2,	NTSC, 40 IRE modulation	$V_{CC} = \pm 5 \text{ V}$		0.06°		
	Channel-to-channel crosstalk (THS4062 only)	V <sub>CC</sub> = ±5 V 0	or ±15 V, f = 1 MHz			65		dB

<sup>†</sup> Full range = 0°C to 70°C for C suffix and –40°C to 85°C for I suffix

#### dc performance

PARAMETER		TEST CONDITIONS†	TEST CONDITIONST			THS4061C/I, THS4062C/I		
				MIN	TYP	MAX		
		V 45V V 40V B 410	T <sub>A</sub> = 25°C	5	15		\//\/	
	Open loop gain	$V_{CC} = \pm 15 \text{ V},  V_{O} = \pm 10 \text{ V},  R_{L} = 1 \text{ k}\Omega$	T <sub>A</sub> = full range	4			V/mV	
Open loop gain		V 15V V 105V D 110	T <sub>A</sub> = 25°C	2.5	8		\//\/	
		$V_{CC} = \pm 5 \text{ V}, \qquad V_{O} = \pm 2.5 \text{ V},  R_{L} = 1 \text{ k}\Omega$	T <sub>A</sub> = full range	2			V/mV	
.,	Input offset voltage	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$			2.5	8	mV	
Vos	Offset drift	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T <sub>A</sub> = full range		15		μV/°C	
I <sub>IB</sub>	Input bias current	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T <sub>A</sub> = full range		3	6	μΑ	
los	Input offset current	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T <sub>A</sub> = full range		75	250	nA	
	Offset current drift	T <sub>A</sub> = full range			0.3		nA/°C	

<sup>†</sup> Full range = 0°C to 70°C for C suffix and -40°C to 85°C for I suffix



# electrical characteristics at T\_A = 25°C, V\_{CC} = $\pm 15$ V, R\_L = 150 $\Omega$ (unless otherwise noted) (continued)

#### input characteristics

PARAMETER		TEST CONDITIONS <sup>†</sup>			TH Th	UNIT		
					MIN	TYP	MAX	
V	Common mode insulturalitana noma	$V_{CC} = \pm 15 \text{ V}$			±13.8	±14.1		.,
VICR	Common-mode input voltage range	V <sub>CC</sub> = ±5 V			±3.8	±4.3		٧
CMDD	Common mode rejection ratio	$V_{CC} = \pm 15 \text{ V},$	$V_{ICR} = \pm 12 V$	T <sub>A</sub> = full range	70	110		dB
CMRR		$V_{CC} = \pm 5 \text{ V},$	V <sub>ICR</sub> = ±2.5 V		70	95		
R <sub>I</sub>	Input resistance		•			1		MΩ
Ci	Input capacitance					2		pF

<sup>†</sup> Full range = 0°C to 70°C for C suffix and -40°C to 85°C for I suffix

#### output characteristics

PARAMETER		TEST CONDITIONS <sup>†</sup>		TH Th	UNIT		
				MIN	TYP	MAX	
		V <sub>CC</sub> = ±15 V	$R_L = 250 \Omega$	±11.5	±12.5		.,
	Output with a second or	V <sub>CC</sub> = ±5 V	$R_L = 150 \Omega$	±3.2	±3.5		V
VO	Output voltage swing	V <sub>CC</sub> = ±15 V	R <sub>L</sub> = 1 kΩ	±13	±13.5		V
		V <sub>CC</sub> = ±5 V		±3.5	±3.7		
	Outract comment	V <sub>CC</sub> = ±15 V	D 00.0	80	115		mA
10	Output current	V <sub>CC</sub> = ±5 V	$R_L = 20 \Omega$	50	75		
Isc	Short-circuit current	V <sub>CC</sub> = ±15 V			150		mA
RO	Output resistance	Open loop			12		Ω

<sup>†</sup> Full range = 0°C to 70°C for C suffix and -40°C to 85°C for I suffix

#### power supply

	PARAMETER	TEST CONDITIONS	st		S4061C S4062C	,	UNIT
				MIN	TYP	MAX	
.,	0	Dual supply		±4.5		±16.5	
V <sub>CC</sub> Supply voltage operating range		Single supply	9		33	V	
		V <sub>CC</sub> = ±15 V	<b>-</b>		7.8	10.5	
ICC	Quiescent current (per amplifier)	V <sub>CC</sub> = ±5 V	T <sub>A</sub> = full range		7.3	10	mA
DCDD Bower awards as in a still			T <sub>A</sub> = 25°C	70	78		
PSRR	Power supply rejection ratio	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T <sub>A</sub> = full range	68			dB

<sup>†</sup> Full range = 0°C to 70°C for C suffix and -40°C to 85°C for I suffix



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# electrical characteristics at T<sub>A</sub> = 25°C, V<sub>CC</sub> = $\pm 15$ V, R<sub>L</sub> = 150 $\Omega$ (unless otherwise noted)

## dynamic performance

					TH	1S4061N	Л	
	PARAMETER		TEST CONDITIONS†		MIN	TYP	MAX	UNIT
	Unity-gain bandwidth	Closed loop,	$R_L = 1 \text{ k}\Omega$	$V_{CC} = \pm 15 \text{ V}$	*140	180		MHz
		V <sub>CC</sub> = ±15 V		0-1- 4		180		N 41 1-
	Dynamic performance small-signal	$V_{CC} = \pm 5 V$		Gain = 1		180		MHz
BW	bandwidth (-3 dB)	$V_{CC} = \pm 15 \text{ V}$				50		
		$V_{CC} = \pm 5 \text{ V}$		Gain = -1		50		MHz
	2	$V_{CC} = \pm 15 \text{ V}$				75		
	Bandwidth for 0.1 dB flatness	V <sub>CC</sub> = ±5 V		Gain = 1		20		MHz
SR	Slew rate	$V_{CC} = \pm 15 \text{ V}$	$R_L = 1 k\Omega$	_	*400	500		V/μs
	0 111 11 1 0 101	$V_{CC} = \pm 15 \text{ V},$	5-V step (0 V to 5 V)			40		
	Settling time to 0.1%	$V_{CC} = \pm 5 \text{ V},$	$V_0 = -2.5 \text{ V to } 2.5 \text{ V},$	Gain = -1		40		ns
t <sub>S</sub>	Cattling times to 0.040/	$V_{CC} = \pm 15 \text{ V},$	5-V step (0 V to 5 V)	Caia 4		140		
	Settling time to 0.01%	$V_{CC} = \pm 5 \text{ V},$	$V_0 = -2.5 \text{ V to } 2.5 \text{ V},$	Gain = -1		150		ns

<sup>†</sup> Full range =  $-55^{\circ}$ C to 125°C for M suffix

#### noise/distortion performance

	24244555		TEST SOURITIONS!	TH				
	PARAMETER		TEST CONDITIONS†	MIN	TYP	MAX	UNIT	
THD	Total harmonic distortion	f = 1 MHz				-72		dBc
٧n	Input voltage noise	f = 10 kHz,	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$			14.5		nV/√ <del>Hz</del>
In	Input current noise	f = 10 kHz,	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$		1.6		pA/√Hz	
	D''' '' '	0	NITOO 40 IDE M 1 I d	V <sub>CC</sub> = ±15 V		0.02		0.4
	Differential gain error	Gain = 2,	NTSC, 40 IRE Modulation	$V_{CC} = \pm 5 \text{ V}$		0.02		%
	Differential phase arror	Coin 2	O : O NITOO 40 IDE M . L L II			0.02°		
	Differential phase error	Gain = 2,	NTSC, 40 IRE Modulation	V <sub>CC</sub> = ±5 V		0.06°		

<sup>†</sup> Full range = -55°C to 125°C for M suffix

#### dc performance

	DADAMETED	TEG	CONDITIONST		TH	UNIT			
	PARAMETER	TEST	TEST CONDITIONS:						
	On an Israe male	$V_{CC} = \pm 15 \text{ V},  V_{O} = \pm 10$	0 V, $R_L = 1 k\Omega$	T 6.11	5	9		\//\/	
	Open loop gain	$V_{CC} = \pm 5 \text{ V}, \qquad V_{O} = \pm 2$	.5 V, $R_L = 1 kΩ$	T <sub>A</sub> = full range	2.5	6		V/mV	
	lament offerst violence	V 15 V on 145 V	D 4160	T <sub>A</sub> = 25°C		2.5	8	mV	
VIO	Input offset voltage	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	$R_L = 1 k\Omega$	T <sub>A</sub> = full range			9	mV	
	Offset drift	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	$R_L = 1 \text{ k}\Omega$	T <sub>A</sub> = full range		15		μV/°C	
lΒ	Input bias current	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	$R_L = 1 k\Omega$	T <sub>A</sub> = full range		3	6	μΑ	
IIO	Input offset current	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	$R_L = 1 \text{ k}\Omega$	T <sub>A</sub> = full range		75	250	nA	
	Offset current drift	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	$R_L = 1 k\Omega$	T <sub>A</sub> = full range		0.3		nA/°C	

<sup>†</sup> Full range =  $-55^{\circ}$ C to 125°C for M suffix



<sup>\*</sup>This parameter is not tested.

# electrical characteristics at $T_A$ = full range, $V_{CC}$ = $\pm 15$ V, $R_L$ = 1 k $\Omega$ (unless otherwise noted) (continued)

#### input characteristics

	242445752	TEGT COMPITIONS!	TI	HS4061N	1	
	PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT
.,	Occurred to the second	$V_{CC} = \pm 15 \text{ V}$	±13.8	±14.1		.,
VICR	Common-mode input voltage range	V <sub>CC</sub> = ±5 V	±3.8	±4.3		V
CMDD	Common mode valuation natio	$V_{CC} = \pm 15 \text{ V}, \qquad V_{ICR} = \pm 12 \text{ V}$	70	86		75
CMRR	Common mode rejection ratio	$V_{CC} = \pm 5 \text{ V}, \qquad V_{ICR} = \pm 2.5 \text{ V}$	80	90		dB
R <sub>I</sub>	Input resistance			1		МΩ
Ci	Input capacitance			2		pF

<sup>†</sup> Full range = -55°C to 125°C for M suffix

#### output characteristics

	242445772			Т	HS4061N	Л	
	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
		V <sub>CC</sub> = ±15 V	$R_L = 250 \Omega$	±12	±13.1		.,
.,	Output walks are suited	V <sub>CC</sub> = ±5 V	$R_L = 150 \Omega$	±3.2	±3.5		V
Vo	Output voltage swing	V <sub>CC</sub> = ±15 V	D 410	±13	±13.5		.,
		V <sub>CC</sub> = ±5 V	$R_L = 1 k\Omega$	±3.5	±3.7		V
	• • •	V <sub>CC</sub> = ±15 V	<b>D 20</b> 0	70	115		
lO	Output current	V <sub>CC</sub> = ±5 V	$R_L = 20 \Omega$	50	75		mA
Isc	Short-circuit current	V <sub>CC</sub> = ±15 V	T <sub>A</sub> = 25°C		150		mA
RO	Output resistance	Open loop			12		Ω

<sup>†</sup> Full range = -55°C to 125°C for M suffix

#### power supply

	24244555	TEGT GOVERNO		TH	UNIT		
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNII	
.,	Complessable and an areation record	Dual supply		±4.5		±16.5	
VCC	Supply voltage operating range	Single supply		9		33	٧
		V <sub>CC</sub> = ±15 V	T. 0500		7.8	9	
١.	Outro and assessed	V <sub>CC</sub> = ±5 V	$T_A = 25^{\circ}C$		7.3	8.5	4
ICC	Quiescent current	V <sub>CC</sub> = ±15 V	T 6.11			11	mA
		V <sub>CC</sub> = ±5 V	T <sub>A</sub> = full range			10.5	
PSRR	Power supply rejection ratio	Vo o - +5 V or +15 V	T <sub>A</sub> = 25°C	76	80		dB
FORK	Power supply rejection ratio	$V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$	T <sub>A</sub> = full range	74	78		ub

<sup>†</sup> Full range =  $-55^{\circ}$ C to 125°C for M suffix

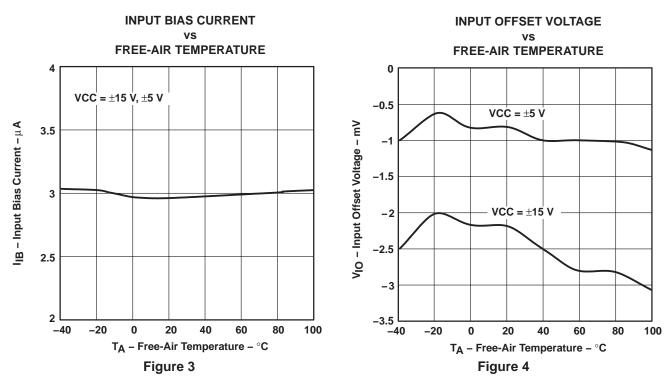


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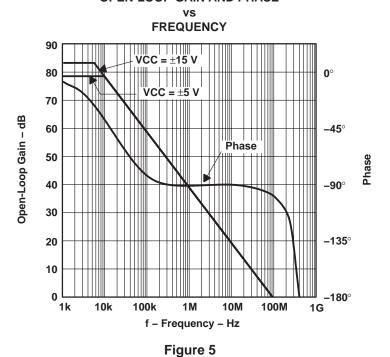
#### **TYPICAL CHARACTERISTICS**

			FIGURE
I <sub>IB</sub>	Input bias current	vs Free-air temperature	3
VIO	Input offset voltage	vs Free-air temperature	4
	Open-loop gain	vs Frequency	5
	Phase	vs Frequency	5
	Differential gain	vs Number of loads	6, 8
	Differential phase	vs Number of loads	7, 9
	Closed-loop gain	vs Frequency	10, 11
	Output amplitude	vs Frequency	12, 13
CMRR	Common-mode rejection ratio	vs Frequency	14
		vs Frequency	15
PSRR	Power supply rejection ratio	vs Free-air temperature	16
V <sub>O(PP)</sub>	Output voltage swing	vs Supply voltage	17
ICC	Supply current	vs Free-air temperature	18
Env	Noise spectral density	vs Frequency	19
THD	Total harmonic distortion	vs Frequency	20, 21
	Crosstalk	vs Frequency	22, 23

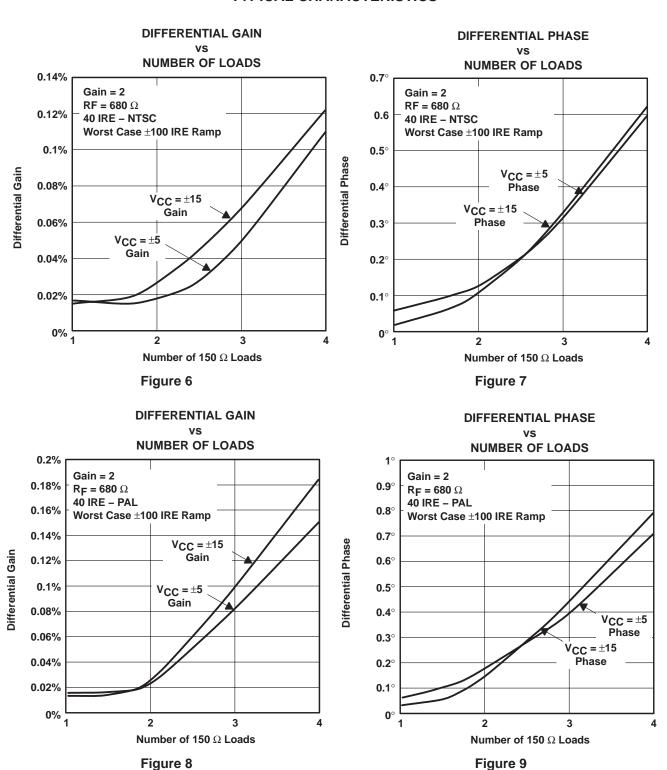
#### **TYPICAL CHARACTERISTICS**



#### **OPEN-LOOP GAIN AND PHASE**



#### TYPICAL CHARACTERISTICS





#### **TYPICAL CHARACTERISTICS**

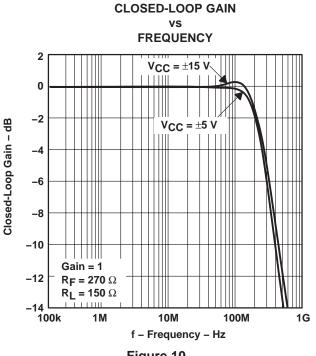
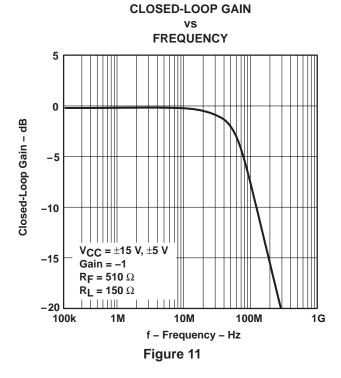


Figure 10



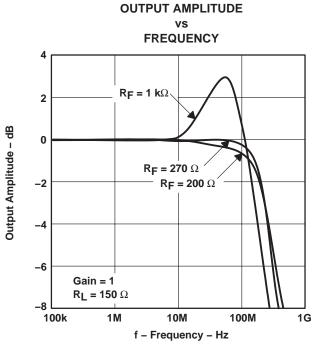
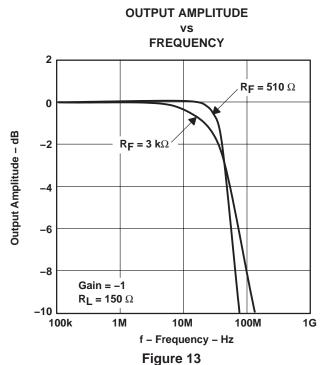


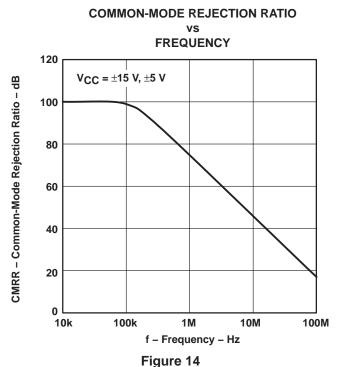
Figure 12



TEXAS INSTRUMENTS

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#### TYPICAL CHARACTERISTICS



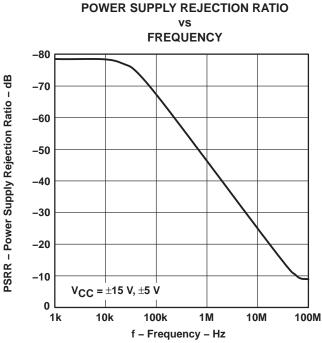
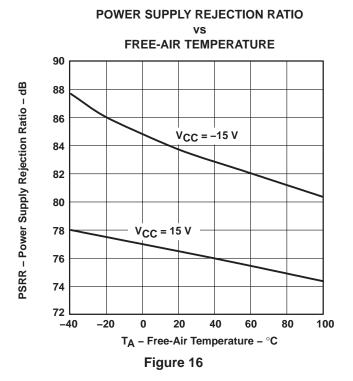
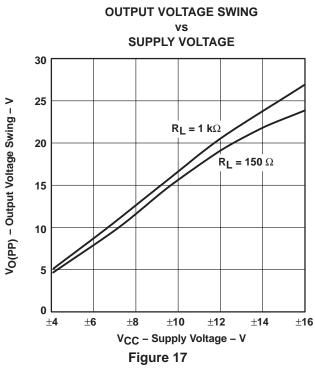
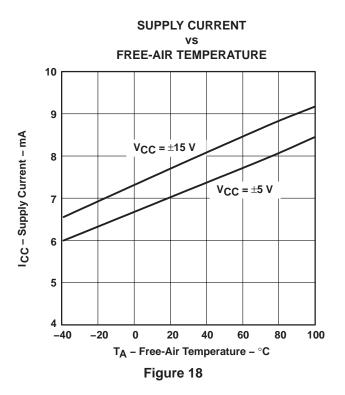


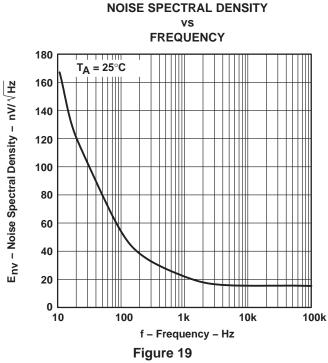
Figure 15

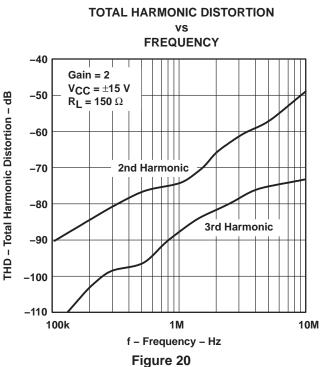


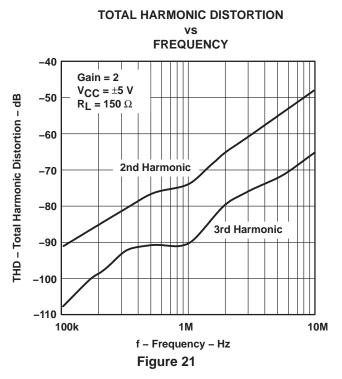


#### **TYPICAL CHARACTERISTICS**

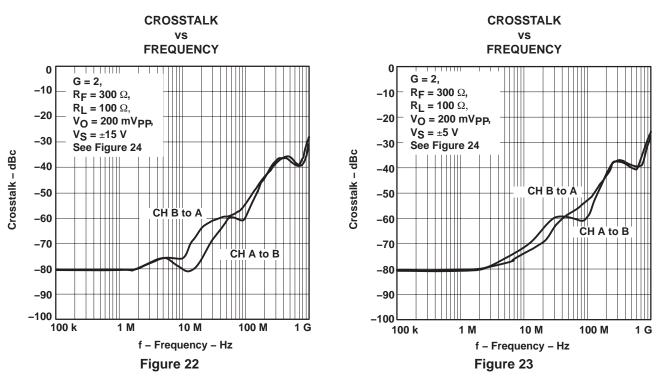








#### TYPICAL CHARACTERISTICS



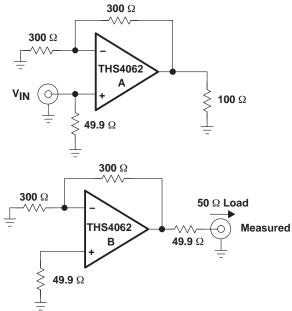


Figure 24. Test Circuits



#### **APPLICATION INFORMATION**

#### theory of operation

The THS406x is a high speed, operational amplifier configured in a voltage feedback architecture. It is built using a 30-V, dielectrically isolated, complementary bipolar process with NPN and PNP transistors possessing  $f_{TS}$  of several GHz. This results in an exceptionally high performance amplifier that has a wide bandwidth, high slew rate, fast settling time, and low distortion. A simplified schematic is shown in Figure 25.

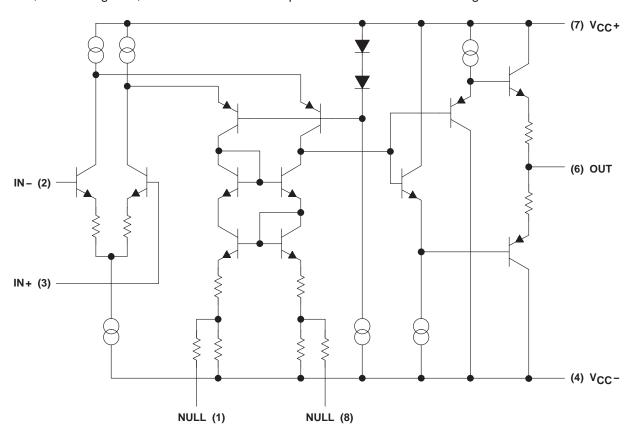


Figure 25. THS4061 Simplified Schematic

#### APPLICATION INFORMATION

#### offset nulling

The THS4061 has very low input offset voltage for a high-speed amplifier. However, if additional correction is required, an offset nulling function has been provided. By placing a potentiometer between terminals 1 and 8 and tying the wiper to the negative supply, the input offset can be adjusted. This is shown in Figure 26.

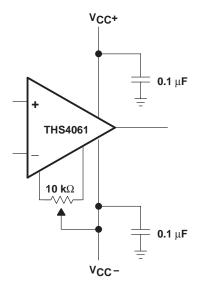


Figure 26. Offset Nulling Schematic

#### optimizing unity gain response

Internal frequency compensation of the THS406x was selected to provide very wideband performance yet still maintain stability when operated in a noninverting unity gain configuration. When amplifiers are compensated in this manner there is usually peaking in the closed loop response and some ringing in the step response for very fast input edges, depending upon the application. This is because a minimum phase margin is maintained for the G=+1 configuration. For optimum settling time and minimum ringing, a feedback resistor of 270  $\Omega$  should be used as shown in Figure 27. Additional capacitance can also be used in parallel with the feedback resistance if even finer optimization is required.

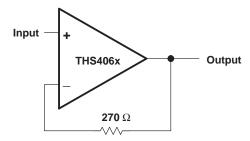


Figure 27. Noninverting, Unity Gain Schematic



#### **APPLICATION INFORMATION**

#### driving a capacitive load

Driving capacitive loads with high performance amplifiers is not a problem as long as certain precautions are taken. The first is to realize that the THS406x has been internally compensated to maximize its bandwidth and slew rate performance. When the amplifier is compensated in this manner, capacitive loading directly on the output will decrease the device's phase margin leading to high frequency ringing or oscillations. Therefore, for capacitive loads of greater than 10 pF, it is recommended that a resistor be placed in series with the output of the amplifier, as shown in Figure 28. A minimum value of 20  $\Omega$  should work well for most applications. For example, in 75- $\Omega$  transmission systems, setting the series resistor value to 75  $\Omega$  both isolates any capacitance loading and provides the proper line impedance matching at the source end.

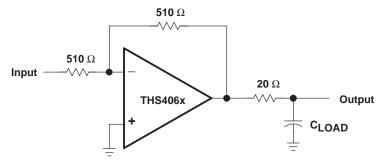


Figure 28. Driving a Capacitive Load

#### circuit layout considerations

In order to achieve the levels of high frequency performance of the THS406x, it is essential that proper printed-circuit board high frequency design techniques be followed. A general set of guidelines is given below. In addition, a THS406x evaluation board is available to use as a guide for layout or for evaluating the device performance.

- Ground planes It is highly recommended that a ground plane be used on the board to provide all
  components with a low inductive ground connection. However, in the areas of the amplifier inputs and
  output, the ground plane can be removed to minimize the stray capacitance.
- Proper power supply decoupling Use a 6.8-μF tantalum capacitor in parallel with a 0.1-μF ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1-μF ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1-μF capacitor should be placed as close as possible to the supply terminal. As this distances increases, the inductance in the connecting trace makes the capacitor less effective. The designer should strive for distances of less than 0.1 inches between the device power terminals and the ceramic capacitors.
- Sockets Sockets are not recommended for high-speed operational amplifiers. The additional lead inductance in the socket pins will often lead to stability problems. Surface-mount packages soldered directly to the printed-circuit board is the best implementation.
- Short trace runs/compact part placements Optimum high frequency performance is achieved when stray series inductance has been minimized. To realize this, the circuit layout should be made as compact as possible thereby minimizing the length of all trace runs. Particular attention should be paid to the inverting input of the amplifier. Its length should be kept as short as possible. This helps to minimize stray capacitance at the input of the amplifier.



#### **APPLICATION INFORMATION**

#### circuit layout considerations (continued)

 Surface-mount passive components – Using surface-mount passive components is recommended for high-frequency amplifier circuits for several reasons. First, because of the extremely low lead inductance of surface-mount components, the problem with stray series inductance is greatly reduced. Second, the small size of surface-mount components naturally leads to a more compact layout, thereby minimizing both stray inductance and capacitance. If leaded components are used, it is recommended that the lead lengths be kept as short as possible.

#### evaluation board

An evaluation board is available for the THS4061 (literature number SLOP226) and THS4062 (literaure number SLOP235). This board has been configured for very low parasitic capacitance in order to realize the full performance of the amplifier. A schematic of the evaluation board is shown in Figure 29. The circuitry has been designed so that the amplifier may be used in either an inverting or noninverting configuration. To order the evaluation board contact your local TI sales office or distributor. For more detailed information, refer to the THS4061 EVM User's Manual (literature number SLOU038) or the THS4062 EVM User's Manual (literature number SLOU040)

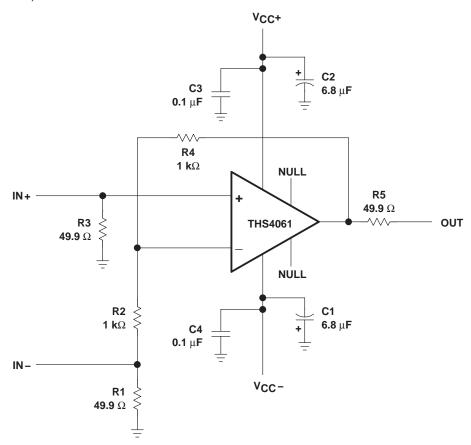


Figure 29. THS4061 Evaluation Board Schematic





# PACKAGE OPTION ADDENDUM

www.ti.com 2-Dec-2023

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9960101Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9960101Q2A THS4061MFKB	Samples
5962-9960101QPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9960101QPA THS4061M	Samples
THS4061CD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	4061C	Samples
THS4061CDG4	ACTIVE	SOIC	D	8	75	TBD	Call TI	Call TI	0 to 70		Samples
THS4061CDGN	ACTIVE	HVSSOP	DGN	8	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ABS	Samples
THS4061CDGNR	ACTIVE	HVSSOP	DGN	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ABS	Samples
THS4061CDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	4061C	Samples
THS4061ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	40611	Samples
THS4061IDG4	ACTIVE	SOIC	D	8	75	TBD	Call TI	Call TI	-40 to 85		Samples
THS4061IDGNR	ACTIVE	HVSSOP	DGN	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT	Samples
THS4061IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	40611	Samples
THS4061MFKB	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9960101Q2A THS4061MFKB	Samples
THS4061MJG	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	THS4061MJG	Samples
THS4061MJGB	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9960101QPA THS4061M	Samples
THS4062CD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	4062C	Samples
THS4062CDG4	ACTIVE	SOIC	D	8	75	TBD	Call TI	Call TI	0 to 70		Samples
THS4062CDGN	ACTIVE	HVSSOP	DGN	8	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ABM	Samples
THS4062CDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	4062C	Samples





#### PACKAGE OPTION ADDENDUM

www.ti.com 2-Dec-2023

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
THS4062ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	40621	Samples
THS4062IDGN	ACTIVE	HVSSOP	DGN	8	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABN	Samples
THS4062IDGNR	ACTIVE	HVSSOP	DGN	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABN	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE OPTION ADDENDUM**

www.ti.com 2-Dec-2023

#### OTHER QUALIFIED VERSIONS OF THS4061, THS4061M:

● Catalog : THS4061

■ Military : THS4061M

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications



# **PACKAGE MATERIALS INFORMATION**

www.ti.com 5-Dec-2023

#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
THS4061CDGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
THS4061CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
THS4061IDGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
THS4061IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
THS4062CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
THS4062IDGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1



# **PACKAGE MATERIALS INFORMATION**

www.ti.com 5-Dec-2023



#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
THS4061CDGNR	HVSSOP	DGN	8	2500	358.0	335.0	35.0
THS4061CDR	SOIC	D	8	2500	350.0	350.0	43.0
THS4061IDGNR	HVSSOP	DGN	8	2500	358.0	335.0	35.0
THS4061IDR	SOIC	D	8	2500	350.0	350.0	43.0
THS4062CDR	SOIC	D	8	2500	350.0	350.0	43.0
THS4062IDGNR	HVSSOP	DGN	8	2500	358.0	335.0	35.0



# **PACKAGE MATERIALS INFORMATION**

www.ti.com 5-Dec-2023

#### **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9960101Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
THS4061CD	D	SOIC	8	75	505.46	6.76	3810	4
THS4061ID	D	SOIC	8	75	505.46	6.76	3810	4
THS4061MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
THS4062CD	D	SOIC	8	75	505.46	6.76	3810	4
THS4062ID	D	SOIC	8	75	505.46	6.76	3810	4

# **GENERIC PACKAGE VIEW**

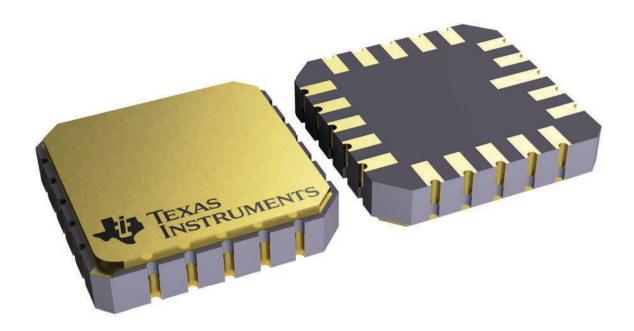
**FK 20** 

LCCC - 2.03 mm max height

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



## **PACKAGE OUTLINE**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



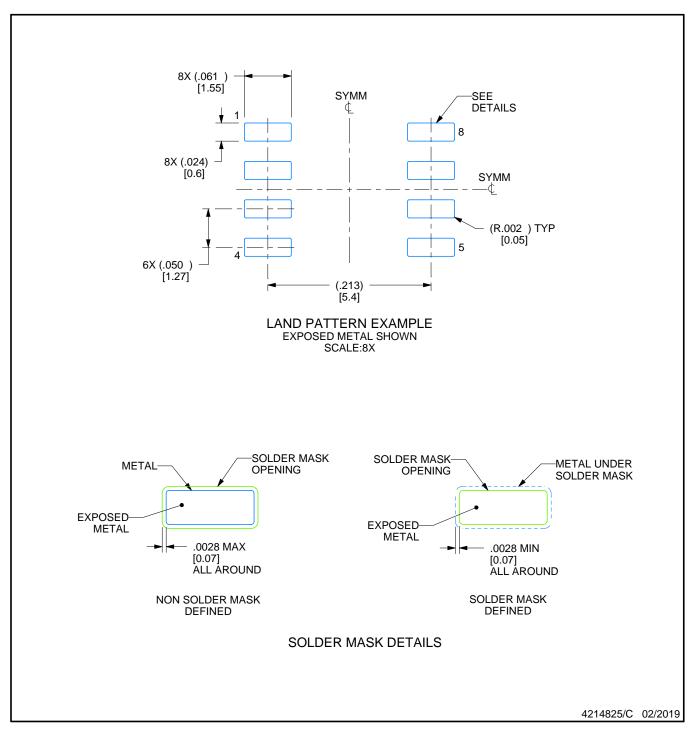
#### NOTES:

**D0008A** 

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



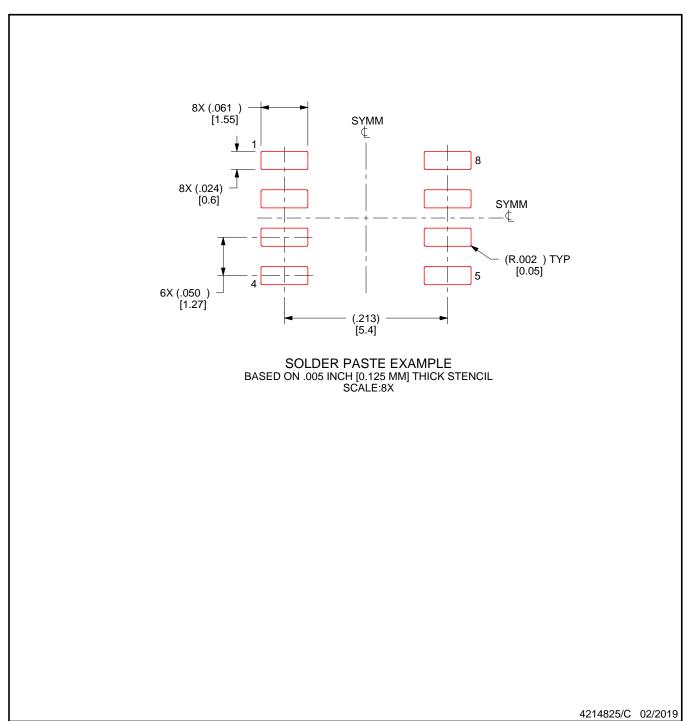
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

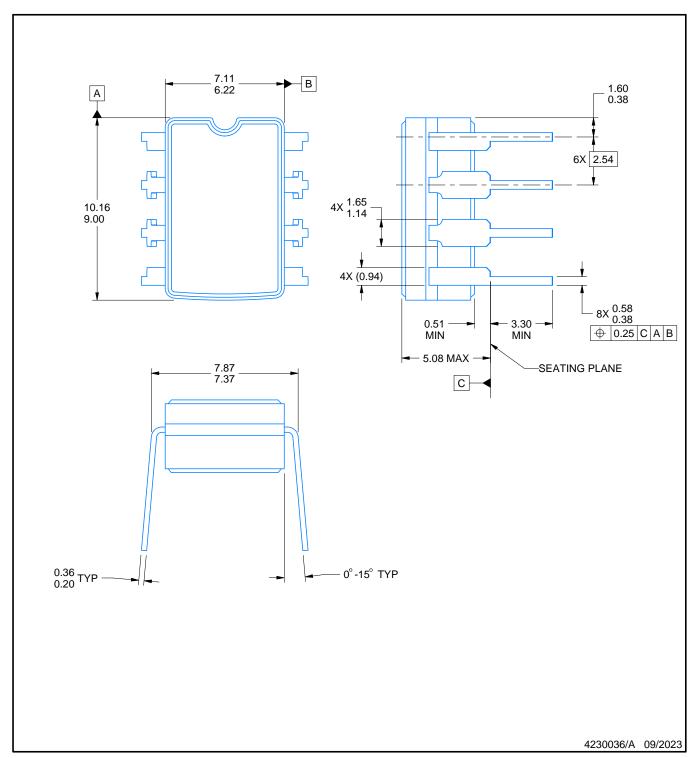


## **PACKAGE OUTLINE**

# **JG0008A**

# CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

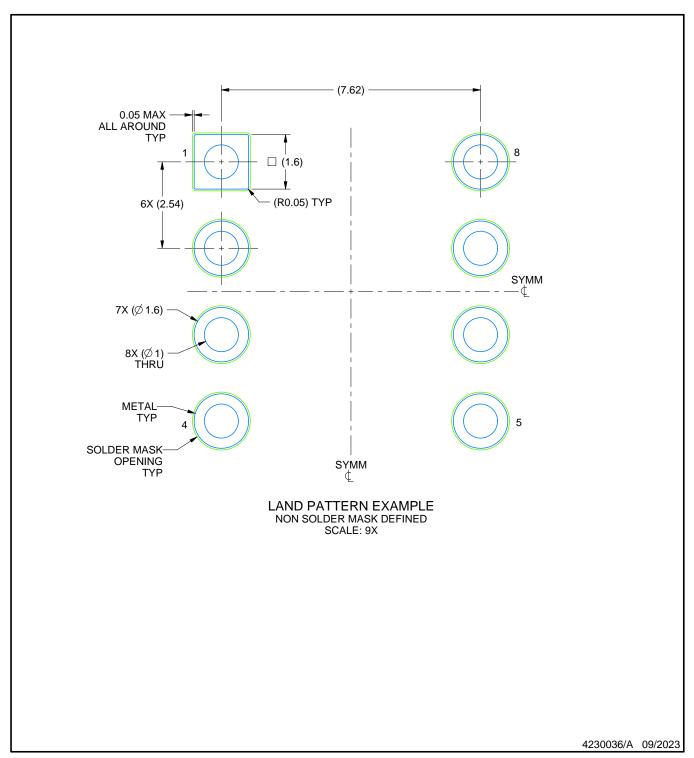
  2. This drawing is subject to change without notice.

  3. This package can be hermetically sealed with a ceramic lid using glass frit.

- 4. Index point is provided on cap for terminal identification. 5. Falls within MIL STD 1835 GDIP1-T8



CERAMIC DUAL IN-LINE PACKAGE



## **GENERIC PACKAGE VIEW**

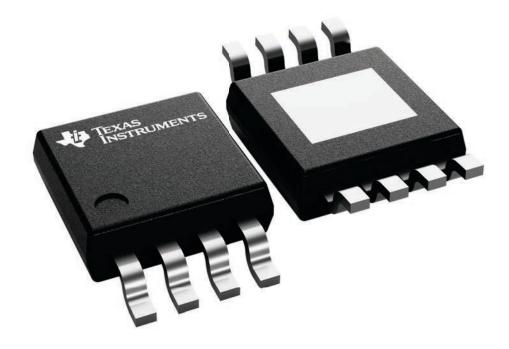
**DGN 8** 

# PowerPAD<sup>™</sup> HVSSOP - 1.1 mm max height

3 x 3, 0.65 mm pitch

SMALL OUTLINE PACKAGE

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



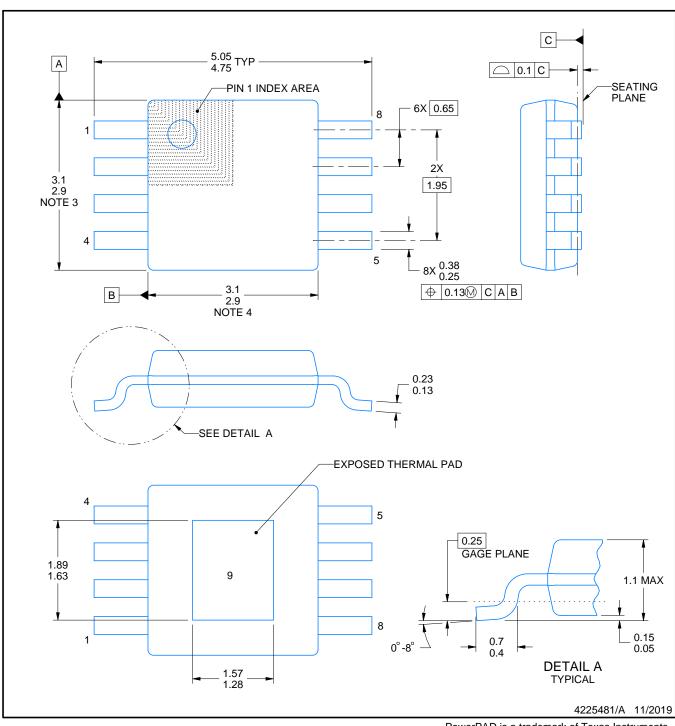
## **PACKAGE OUTLINE**

# PowerPAD<sup>™</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



**DGN0008D** 



#### NOTES:

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- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

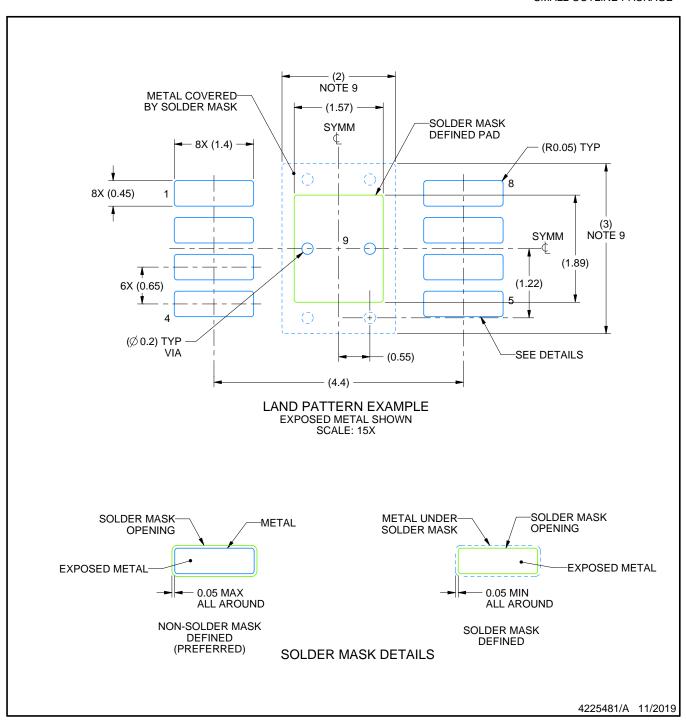
  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



# PowerPAD<sup>™</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



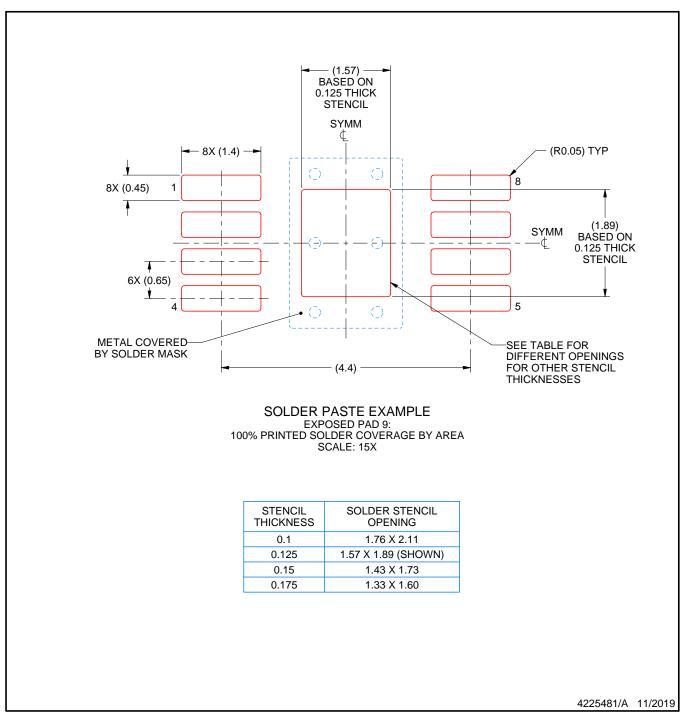
#### NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



# PowerPAD<sup>™</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 11. Board assembly site may have different recommendations for stencil design.



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